



# **PRODUCT DATA SHEET**



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Datasheet

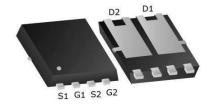
Samples

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO\_questions@jgsemi.com.



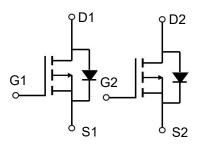
**Dual P-Ch 20V MOSFETs** 

BVDSS	RDSON	ID
-20V	12mΩ	-30A



- ★ Super Low Gate Charge
- ★ Green Device Available
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology





# **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-Source Voltage	±12	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ -4.5V <sup>1</sup>	-30	А
I <sub>D</sub> @T <sub>C</sub> =70°C	Continuous Drain Current, V <sub>GS</sub> @ -4.5V <sup>1</sup>	-18	А
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	-68	А
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>3</sup>	18	W
P <sub>D</sub> @T <sub>C</sub> =70°C	Total Power Dissipation <sup>3</sup>	12	W
T <sub>STG</sub>	T <sub>STG</sub> Storage Temperature Range		°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

## **Thermal Data**

Symbol	Parameter		Unit
ReJA	Thermal Resistance Junction-Ambient <sup>1</sup>	75	°C/W
RθJA	Thermal Resistance Junction-Ambient ¹ (t ≤10s)	40	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	4.2	°C/W



# Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-20			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV <sub>DSS</sub> Temperature Coefficient Reference to 25°C , I <sub>D</sub> =-1mA			-0.012		V/°C
		V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-10A		12	15	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-2.5V , I <sub>D</sub> =-8A		16	20	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	-V <sub>GS</sub> =V <sub>DS</sub> . In =-250uA	-0.4	-0.7	-1.0	V
$\Delta V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	VGS-VDS , ID250UA		2.94		mV/°C
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 12 \text{ V}$ , $V_{DS}$ =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =-5V , I <sub>D</sub> =-10A		43		S
Qg	Total Gate Charge (-4.5V)			35		
$Q_{gs}$	Gate-Source Charge	V <sub>DS</sub> =-10V , V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-10A		5.0		nC
Q <sub>gd</sub>	Gate-Drain Charge			10		
T <sub>d(on)</sub>	Turn-On Delay Time			12.0		
Tr	Rise Time	$V_{DD}$ =-10V , $V_{GS}$ =-4.5V ,		40.0		no
$T_{d(off)}$	Turn-Off Delay Time	$R_G=3.3\Omega$ , $I_D=-10A$		30		ns
T <sub>f</sub>	Fall Time			10		
Ciss	Input Capacitance			2800		
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		690		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			590		

## **Diode Characteristics**

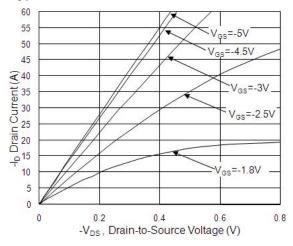
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current <sup>1,4</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-30.0	Α
Ism	Pulsed Source Current <sup>2,4</sup>	V <sub>G</sub> -V <sub>D</sub> -0V , Force Current				Α
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	$V_{GS}$ =0V , $I_{S}$ =-1A , $T_{J}$ =25 $^{\circ}$ C			-1.2	V
t <sub>rr</sub>	Reverse Recovery Time	IF=-10A , dI/dt=100A/μs ,		27		nS
Q <sub>rr</sub>	Reverse Recovery Charge	T <sub>J</sub> =25°C		17.8		nC

#### Note:

- 1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq\!300\text{us}$  , duty cycle  $\leq\!2\%$
- 3. The power dissipation is limited by 150°C junction temperature
- 4. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



## **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

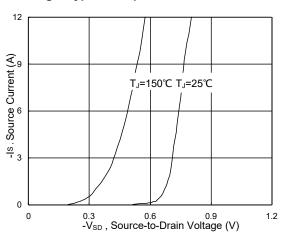


Fig.3 Forward Characteristics of Reverse

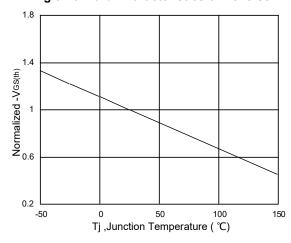


Fig.5 Normalized  $V_{\text{GS(th)}}$  vs.  $T_{\text{J}}$ 

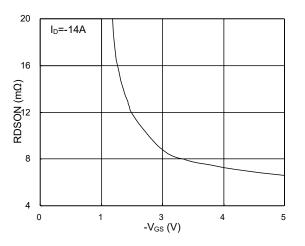


Fig.2 On-Resistance vs. G-S Voltage

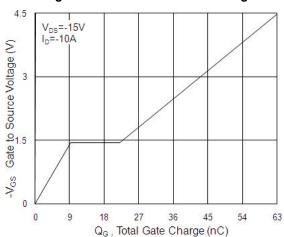


Fig.4 Gate-charge Characteristics

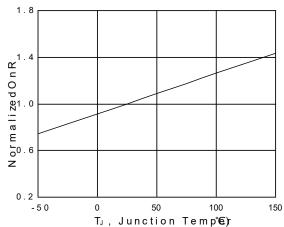
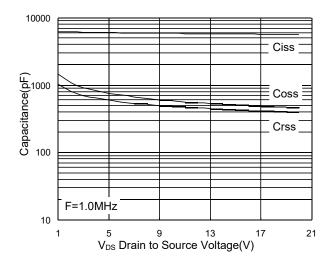


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>





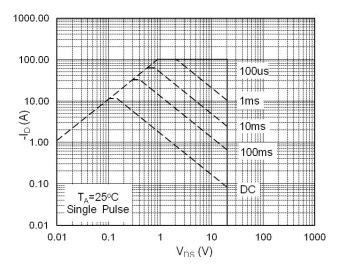


Fig.7 Capacitance

Fig.8 Safe Operating Area

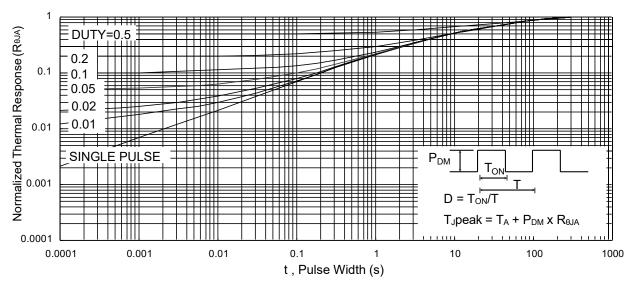
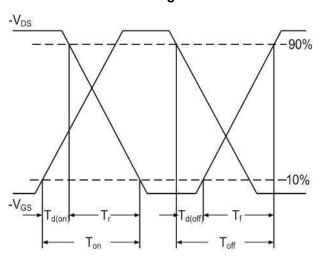


Fig.9 Normalized Maximum Transient Thermal Impedance



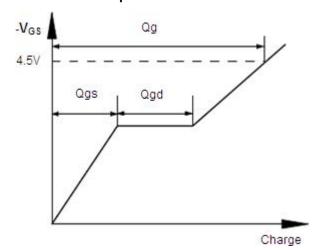
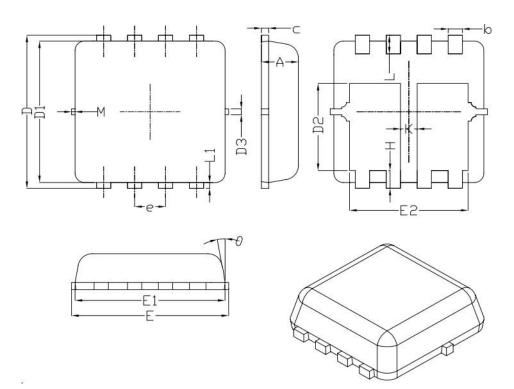


Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform



# Dual PDFN3333-8L Package Outline Data



Cumbal	Dimensions (unit: mm)			
Symbol	Min	Тур	Max	
Α	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.78	1.88	1.98	
D3		0.13		
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65 BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1		0.13		
K	0.30	-		
θ		10°	12°	
М	*	*	0.15	
* Not Specified				

#### Notes:

- 1. Refer to JEDEC MO-240 variation CA.
- 2. Dimensions "D1" and "E1" do NOT include mold flash protrusions or gate burrs
- 3. Dimensions "D1" and "E1" include interterminal flash or protrusion.



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